

Immersion probe set for determination of the temperature coefficient (CT)

**Operating instructions** 



Fig. 1. Immersion probe set, Order-No. 07163.00

#### 1. PURPOSE AND DESCRIPTION

Using the immersion probe set in Fig. 1, the electrical properties of different electronic components and materials can be investigated at defined temperatures (up to approximately  $100^{\circ}$  C). The immersion probe set contains the following components:

- Carbon-film resistor
- Metallic film resistor, TC 50
- PTC resistor
- NTC resistor
- Copper wire
- Constantan wire
- Silicon diode
- Germanium diode
- Z diode, 2.7 v
- Z diode, 6.8 V

# 2. USE

The immersion probe set first enclosed in a heat-resistance plastic bag (contained in the delivery set) and then placed in a temperature-controlled water bath. In this manner, the following parameters can be measured as a function of the (exactly adjustable) temperature:

- Resistance of conductors (metals)
- Resistance of semi-conductors
- Diode threshold voltage (Si, Ge)
- Diode blocking voltage (Si, Ge)
- Z voltage for the Zener effect
- Z voltage by the avalanche effect

From the measured values, additional parameters, such as the temperature coefficient, can be calculated.

Fig. 2 shows an appropriate experimental set up. Assuming a lower water temperature by full output of the circulating thermoregulator, it is advisable to perform nearly all of the 10 K measurements either during the warming or (after reaching the maximum temperature and switching off the heating) during the cool-down phase. The resistance values are directly measured with the digital multimeter. The diode voltages are measured after the diodes have been connected to a voltage of 10 V- across a 4.7 k $\Omega$ resistor.

The plastic bag should fit as tightly as possible around the immersion probe set. For this reason press out the air before immersing the probe set. Do not immerse the set in water without its protective plastic bag.!

Fig. 2. Experimental set-up for measuring the temperature dependence of electrical characteristics of electronic components.









Fig. 3. The threshold voltage of semiconducting diodes as a function of the temperature.



Fig. 5. Blocking voltage of Z diodes as a function of temperature.

#### 3. SAMPLE MEASUREMENTS

The diagrams show a selection of the measuring results. The different signs of temperature coefficient of the blocking voltage of two Z diodes (Fig. 3), which results from the avalanche and Zener effects, is very clearly shown. In practice, Z diodes with a Z voltage of approximately 5 V are used to generate particularly stable reference voltages, as in this case the temperature coefficient is nearly zero.

From the measured values for the copper wire (Fig. 4), the temperature coefficient  $\alpha_R$  is calculated according to

$$\alpha_{R} = \frac{R - R_{a}}{R_{a}(\vartheta - \vartheta_{a})}$$

 $R(\vartheta_a = initial \text{ temperature}, \vartheta = final \text{ temperature}, R = resistance at \vartheta, R_a = resistance at \vartheta_a)$  to be equal to the following:

 $\alpha_R$  = 3.91  $\cdot$  10<sup>-3</sup>  $^oC^{-1}$  (copper). This value corresponds very well with the corresponding literature values.

The nearly linear correlation between threshold voltage and temperature for semiconducting diodes (Fig. 5) is also interesting. Due to this, the threshold voltage can also be used for making temperature measurements.

#### 4. TECHNICAL DATA

<b>Z diodes</b> (at T <sub>amb</sub> = 25° C	ZPD 2.7	ZPD 6.8
Rated voltage $U_z$ at $I_z$ = 5 mA Output Operating current Temperature coefficient CT	2.7 ±7.41% max 0.5 W max 160 mA -94 · 10 <sup>-4</sup> /K	5.8 ±5.9% max 0.5 W max 58 mA +2 +7 · 10 <sup>-4</sup> /K
Si diode (1 N 4005) Threshold voltage $U_F$ at 0.1 A Nominal current Blocking current at $U_R$ = 800 V, $T_i$ = 25° C		approx. 0.55 V 1 A max. 5A
Ge diode (AA 118) Threshold voltage $U_F$ at $I_F$ = 10 mA at $I_F$ = 0.1 mA Continuous average forward current at $U_R$ = 75 V, $T_{amb}$ = 75° C Blocking current at $U_R$ = 75 V,		typ. 1.05 V typ. 0.18 V nt max. 5 mA typ. 35 μA
PTC resistor (Posistor, Type Q Cold resistance at Initial temperature (Start of pos. TC) Initial resistance a Nominal resistance Tc in steepest regio of the characterist Limit temperature	$T_{amb} = 25^{\circ} C$ t 30° C e at 60° C on	2, SIEMENS) approx. 60 Ω 30° C 30 Ω 100 Ω 20%/K max 140° C

### **NTC resistor**

VALVO)
1300 Ω ±20%
60 s
5450 K
-6.15%/K
max 1 W

### Metal film resistor

Nominal resistance Temperature coefficient Output at  $T_u = 70^\circ$  C

#### Carbon-film resistor

Nominal resistance	1 kΩ
Temperature coefficient	-240
Output at <i>T<sub>amb</sub></i> = 70° C	max

### Copper wire resistor

Resistance at $T_{amb}$ = 20° C
Wire-Cu diameter
Wire length
Temperature coefficient
Loading current

## CuNi wire resistor (constantan)

Resistance at $T_{amb}$ = 20° C	17
Wire-Cu diameter	0.
Wire length	ap
Temperature coefficient	-3
Loading current	m

### **Other Values**

Immersion width and
depth of the device
Width of the upper cross bridge
Freezer bag dimensions (w x l)
Connection jacks, diameter
Operating temperature

1 kΩ ±2% ±0 ... 50 · 10<sup>-6</sup>/K max 0.5 W

1 kΩ ±5% -240 · 10<sup>-6</sup>/K max 0.5 W

# 351 Ω ±1% 0.05 mm approx. 40 m 0.004/K max 5 mA

172 Ω ±1% 0.2 mm approx. 11 m -3 · 10<sup>-5</sup>/K max 50 mA

100 mm x 105 mm 180 mm 180 mm x 250 mm 4 mm max 100° C

#### 5. EQUIPMENT ORDER-NO. PCS